

S30P32DNF

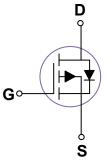
30V P-Channel MOSFETs

General Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

DFN2020-8 Pin Configuration





BV_{DSS}	R _{DS(ON)} Max.	I _D
-30V	$32 m\Omega$	-6.5A

Features

- -30V, -6.5A, $R_{DS(ON)}Max. = 32m\Omega @V_{GS} = -10V$
- Fast switching
- Green Device Available
- Suit for -4.5V Gate Drive Applications

Applications

- Notebook
- Load Switch
- Battery Protection
- Hand-held Instruments

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	-30	V
V _{GS}	Gate-Source Voltage	±12	V
I	Drain Current – Continuous (T _C =25°C)	-6.5	А
D	Drain Current – Continuous (T _C =100°C)	-4.3	А
l _{DM}	Drain Current – Pulsed ¹	-42	А
E _{AS}	Single Pulse Avalanche Energy ²	78.4	mJ
AS	Single Pulse Avalanche Current ²	56	A
P	Power Dissipation (T _C =25°C)	1.56	W
P _D	Power Dissipation – Derate above 25°C	0.012	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction to ambient		80	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30			V
$\triangle BV_{DSS} / \triangle T_J$	BV _{DSS} Temperature Coefficient	Reference to 25°C,I _D =-1mA		-0.03		V/°C
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-30V , V _{GS} =0V , T _J =25°C			-1	uA
		V _{DS} =-24V , V _{GS} =0V , T _J =125°C			-10	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA

On Characteristics

R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-10V , I _D =-4A		29	32	mΩ	
		V _{GS} =-4.5V , I _D =-2A		38	46	mΩ	
V _{GS(th)}	Gate Threshold Voltage	$V_{GS}=V_{DS}$, I_D =-250uA	-0.5	-1.0	-1.5	V	
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			4		mV/°C	
gfs	Forward Transconductance	V _{DS} =-10V , I _D =-3A		9		S	

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2,3}		8	
Q_gs	Gate-Source Charge ^{2,3}	V_{DS} =-15V , V_{GS} =-4.5V , I_D =-5A	3.3	nC
Q_{gd}	Gate-Drain Charge ^{2,3}		2.3	
T _{d(on)}	Turn-On Delay Time ^{2 , 3}		4.6	
Tr	Rise Time ^{2,3}	V_{DD} =-15V , V_{GS} =-10V , R_{G} =6 Ω	14	ns
T _{d(off)}	Turn-Off Delay Time ^{2 , 3}	I _D =-1A	34	115
T _f	Fall Time ^{2,3}		18	
Ciss	Input Capacitance		757	
C _{oss}	Output Capacitance	V_{DS} =-15V , V_{GS} =0V , F=1MHz	122	pF
C _{rss}	Reverse Transfer Capacitance		88	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	$V_G = V_D = 0V$, Force Current			-6.5	А
I _{SM}	Pulsed Source Current				-32	А
V_{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =-1A , T _J =25°C			-1	V

Note :

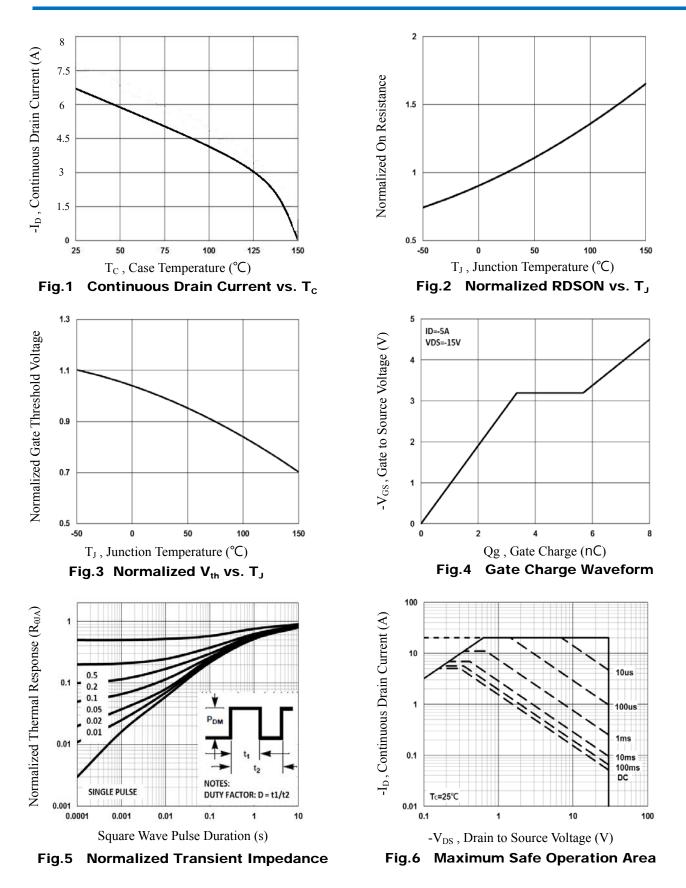
1. Repetitive Rating : Pulsed width limited by maximum junction temperature.

2. The data tested by pulsed , pulse width \leq 300us , duty cycle $\leq\,2\%.$

3. Essentially independent of operating temperature.



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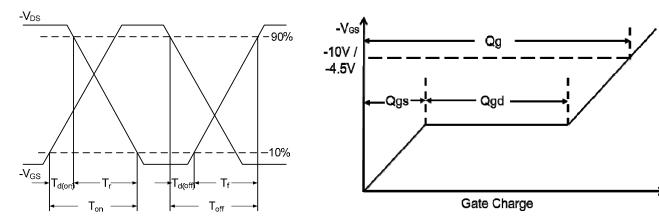


Fig.7 Switching Time Waveform

Fig.8 Gate Charge Waveform



V 1.0

DFN2020-8 PACKAGE INFORMATION

